







**OPA182, OPA2182, OPA4182**SBOS936E – NOVEMBER 2019 – REVISED AUGUST 2022

# OPAx182 36-V, 5-MHz, Low-Noise, Zero-Drift, MUX-Friendly, Precision Op Amps

#### 1 Features

· Ultra-high precision:

Zero-drift: 0.003 μV/°C

Ultra-low offset voltage: 4 μV (maximum)

Excellent dc precision:

- CMRR: 168 dB

Open-loop gain: 170 dB

· Low noise:

e<sub>n</sub> at 1 kHz: 5.7 nV/√Hz

- 0.1-Hz to 10-Hz noise: 0.12  $\mu V_{PP}$ 

Excellent dynamic performance:

Gain bandwidth: 5 MHz

Slew rate: 10 V/μs

Fast settling: 10-V step, 0.01% in 1.7 μs

· Robust design:

- MUX-friendly inputs

- RFI and EMI filtered inputs

Wide supply: ±2.25 V to ±18 V, 4.5 V to 36 V

Quiescent current: 0.85 mA

· Rail-to-rail output

· Input includes negative rail

# 2 Applications

- · Battery test
- · DC power supply, ac source, electronic load
- Data acquisition (DAQ)
- · Semiconductor test
- Weigh scale
- · Analog input module
- Flow transmitter

#### 3 Description

The OPA182, OPA2182, and OPA4182 (OPAx182) are ultra-low noise, fast-settling, zero-drift, high-precision operational amplifiers, These devices provide rail-to-rail output operation and feature a unique MUX-friendly architecture and controlled start-up system. These devices also feature excellent ac performance combined with only 0.45  $\mu V$  of offset voltage and 0.003  $\mu V/^{\circ} C$  of drift over temperature. All these features make the OPAx182 a great choice for data acquisition, battery test, analog input modules, weigh scales, and any other systems requiring high dc precision and low noise.

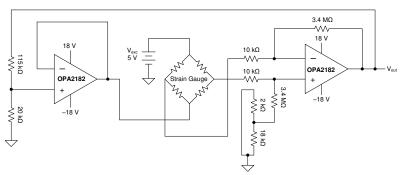
The MUX-friendly input architecture prevents inrush current when applying large input differential voltages and improves settling performance in multichannel systems. Moreover, the controlled start-up system rejects any inrush current when ramping up the supply rails, all while providing robust ESD protection during shipment, handling, and assembly.

The device is specified from -40°C to +125°C.

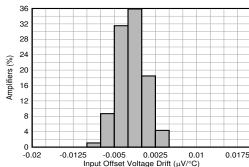
#### **Package Information**

| PART NUMBER | PACKAGE <sup>(1)</sup> | BODY SIZE (NOM)   |  |
|-------------|------------------------|-------------------|--|
| OPA182      | D (SOIC, 8)            | 4.90 mm x 3.90 mm |  |
| UPA162      | DBV (SOT-23, 5)        | 2.90 mm x 1.60 mm |  |
| OPA2182     | D (SOIC, 8)            | 4.90 mm x 3.90 mm |  |
| OPA2162     | DGK (VSSOP, 8)         | 3.00 mm x 3.00 mm |  |
| OPA4182     | D (SOIC, 14)           | 8.65 mm x 3.91 mm |  |
| OI A4 102   | PW (TSSOP, 14) Preview | 5.00 mm x 4.40 mm |  |

 For all available packages, see the package option addendum at the end of the data sheet.



**OPA2182 Bridge Sensor Application** 



**OPAx182 Offset Drift** 



## **Table of Contents**

| 1 Features                           | 1              | 8.3 Feature Description                              | 19              |
|--------------------------------------|----------------|--|-----------------|
| 2 Applications                       |                | 8.4 Device Functional Modes                          |                 |
| 3 Description                        | 1              | 9 Application and Implementation                     | 23              |
| 4 Revision History                   |                | 9.1 Application Information                          |                 |
| 5 Device Comparison Table            | 3              | 9.2 Typical Applications                             |                 |
| 6 Pin Configuration and Functions    | 4              | 9.3 Power Supply Recommendations                     |                 |
| 7 Specifications                     | 6              | 9.4 Layout   |                 |
| 7.1 Absolute Maximum Ratings         | 6              | 10 Device and Documentation Support                  | 31              |
| 7.2 ESD Ratings                      | 6              | 10.1 Device Support                                  | 31              |
| 7.3 Recommended Operating Conditions | 6              | 10.2 Documentation Support                           | 31              |
| 7.4 Thermal Information: OPA182      | <mark>7</mark> | 10.3 Receiving Notification of Documentation Updates | <mark>31</mark> |
| 7.5 Thermal Information: OPA2182     | <mark>7</mark> | 10.4 Support Resources                               | 32              |
| 7.6 Thermal Information: OPA4182     | <mark>7</mark> | 10.5 Trademarks                                      |                 |
| 7.7 Electrical Characteristics       | 8              | 10.6 Electrostatic Discharge Caution                 | 32              |
| 7.8 Typical Characteristics          | 10             | 10.7 Glossary  | 32              |
| 8 Detailed Description               |                | 11 Mechanical, Packaging, and Orderable              |                 |
| 8.1 Overview                         | 18             | Information  | 32              |
| 8.2 Functional Block Diagram         | 18             |  |                 |
| 8 Detailed Description               | 18<br>18       |  |                 |

| Changes from Revision D (December 2021) to Revision E (August 2022)   | Page |
|---|------|
| <ul> <li>Changed OPA182 DBV (SOT-23) package from preview to active and added associated content</li> </ul> | 1    |
| Changes from Revision C (January 2021) to Revision D (December 2021)  | Page |
| Added OPA182 and OPA4182 production data (active) devices and associated content                            | 1    |
| Changes from Revision B (July 2020) to Revision C (January 2021)  | Page |
| Changed VSSOP-8 (DGK) package from preview to production data (active)                                      | 1    |
| Changes from Revision A (May 2020) to Revision B (July 2020)  | Page |
| Added VSSOP-8 (DGK) preview package and associated content to data sheet                                    | 1    |
| Changed capacitive load drive specification from "TBD" to "See Typical Characteristics"                     | 8    |
| Changes from Revision * (December 2019) to Revision A (May 2020)  | Page |
| Changed device status from advanced information (preview) to production data (active)                       | 1    |

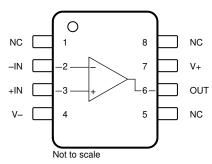


# **5 Device Comparison Table**

| PRODUCT | FEATURES   |
|---------|--|
| OPA2189 | 0.4-μV offset, 0.005-μV/°C drift, 5.2-nV/√Hz, rail-to-rail output, 36-V, zero-drift, MUX-friendly CMOS                             |
| OPA2188 | 6-μV offset, 0.03-μV/°C drift, 8.8-nV/√Hz, rail-to-rail output, 36-V, zero-drift, MUX-friendly CMOS                                |
| OPA2187 | 1-μV offset, 0.001-μV/°C drift, 100-μA quiescent current, rail-to-rail output, 36-V, zero-drift CMOS                               |
| OPA2388 | 0.25-μV offset, 0.005-μV/°C drift, 7-nV/√Hz, 10-MHz, <i>true</i> rail-to-rail input/output, 5.5-V, zero-drift, zero-crossover CMOS |
| OPA2180 | 120-μV, 10-MHz, 5.1-nV/√Hz, 36-V JFET input industrial op amp  |



# **6 Pin Configuration and Functions**



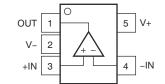


Figure 6-2. OPA182 DBV (5-Pin SOT-23) Package, Top View

Figure 6-1. OPA182 D (8-Pin SOIC) Package, Top View

Table 6-1. Pin Functions: OPA182

|      | PIN      |                 |        |   |  |
|------|----------|-----------------|--------|---|--|
| NAME | D (SOIC) | DBV<br>(SOT-23) | TYPE   | DESCRIPTION                                   |  |
| -IN  | 2        | 4               | Input  | Inverting input                               |  |
| +IN  | 3        | 3               | Input  | Noninverting input                            |  |
| NC   | 1, 5, 8  | _               | _      | No internal connection; can be left floating. |  |
| OUT  | 6        | 1               | Output | Output channel                                |  |
| V-   | 4        | 2               | Power  | Negative supply                               |  |
| V+   | 7        | 5               | Power  | Positive supply                               |  |

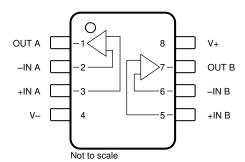


Figure 6-3. D (8-Pin SOIC) and DGK (8-Pin VSSOP) Packages, Top View

Table 6-2. Pin Functions: OPA2182

| PIN   |     | TYPE   | DESCRIPTION                  |  |
|-------|-----|--------|------------------------------|--|
| NAME  | NO. | ITPE   | DESCRIPTION                  |  |
| −IN A | 2   | Input  | Inverting input channel A    |  |
| +IN A | 3   | Input  | Noninverting input channel A |  |
| –IN B | 6   | Input  | Inverting input channel B    |  |
| +IN B | 5   | Input  | Noninverting input channel B |  |
| OUT A | 1   | Output | Output channel A             |  |
| OUT B | 7   | Output | Output channel B             |  |
| V-    | 4   | Power  | Negative supply              |  |
| V+    | 8   | Power  | Positive supply              |  |



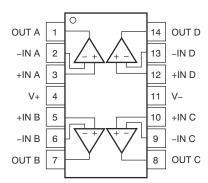


Figure 6-4. D (14-Pin SOIC) and PW (14-Pin TSSOP, Preview) Packages, Top View

Table 6-3. Pin Functions: OPA4182

| F     | PIN |        | PERCENTION                   |  |
|-------|-----|--------|------------------------------|--|
| NAME  | NO. | - TYPE | DESCRIPTION                  |  |
| -IN A | 2   | Input  | Inverting input channel A    |  |
| +IN A | 3   | Input  | Noninverting input channel A |  |
| –IN B | 6   | Input  | Inverting input channel B    |  |
| +IN B | 5   | Input  | Noninverting input channel B |  |
| –IN C | 9   | Input  | Inverting input channel C    |  |
| +IN C | 10  | Input  | Noninverting input channel C |  |
| –IN D | 13  | Input  | Inverting input channel D    |  |
| +IN D | 12  | Input  | Noninverting input channel D |  |
| OUT A | 1   | Output | Output channel A             |  |
| OUT B | 7   | Output | Output channel B             |  |
| OUT C | 8   | Output | Output channel C             |  |
| OUT D | 14  | Output | Output channel D             |  |
| V-    | 11  | Power  | Negative supply              |  |
| V+    | 4   | Power  | Positive supply              |  |



# 7 Specifications

# 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

|                  | ·                                   |                                  | MIN        | MAX                  | UNIT |
|------------------|-------------------------------------|----------------------------------|------------|----------------------|------|
| \/-              | Supply voltage                      | Single-supply, $V_S = (V+)$      |            | 40                   | V    |
| Vs               | Supply voltage                      | Dual-supply, $V_S = (V+) - (V-)$ |            | ±20                  | V    |
|                  |                                     | Common-mode                      | (V-) - 0.5 | (V+) + 0.5           |      |
|                  | Signal input voltage                | Differential                     |            | (V+) - (V-) +<br>0.2 | V    |
|                  | Current                             |                                  |            | ±10                  | mA   |
|                  | Output short circuit <sup>(2)</sup> |                                  | Continuous | Continuous           |      |
| T <sub>A</sub>   | Operating temperature               |                                  | -55        | 150                  | °C   |
| TJ               | Junction temperature                |                                  |            | 150                  | °C   |
| T <sub>stg</sub> | Storage temperature                 |                                  | -65        | 150                  | °C   |

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 7.2 ESD Ratings

|  |   |   | VALUE | UNIT |
|--|---|---|-------|------|
| V  | V Floatusetatio dischause   | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup> | ±4000 | \/   |
| V <sub>(ESD)</sub> Electrostatic discharge | Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup> | ±1000   | V     |      |

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safemanufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                               |                       |                                  | MIN   | NOM MAX | UNIT |
|-------------------------------|-----------------------|----------------------------------|-------|---------|------|
| V <sub>S</sub> Supply voltage | Supply voltage        | Single-supply, $V_S = (V+)$      | 4.5   | 36      | .,   |
|                               | Supply voltage        | Dual-supply, $V_S = (V+) - (V-)$ | ±2.25 | ±18     | v    |
| T <sub>A</sub>                | Operating temperature |                                  | -40   | 125     | °C   |

<sup>(2)</sup> Short-circuit to ground, one amplifier per package.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safemanufacturing with a standard ESD control process.

### 7.4 Thermal Information: OPA182

|                       |  | OF       | OPA182       |      |  |
|-----------------------|--|----------|--------------|------|--|
|                       | THERMAL METRIC <sup>(1)</sup>                | D (SOIC) | DBV (SOT-23) | UNIT |  |
|                       |  | 8 PINS   | 5 PINS       |      |  |
| R <sub>0JA</sub>      | Junction-to-ambient thermal resistance       | 112.9    | 138.2        | °C/W |  |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 50.8     | 63.8         | °C/W |  |
| R <sub>θJB</sub>      | Junction-to-board thermal resistance         | 56.2     | 35.5         | °C/W |  |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 10.1     | 17.1         | °C/W |  |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 55.4     | 35.4         | °C/W |  |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | N/A      | N/A          | °C/W |  |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

#### 7.5 Thermal Information: OPA2182

|                       |  | OPA      | OPA2182     |      |  |
|-----------------------|--|----------|-------------|------|--|
|                       | THERMAL METRIC <sup>(1)</sup>                | D (SOIC) | DGK (VSSOP) | UNIT |  |
|                       |  | 8 PINS   | 8 PINS      |      |  |
| $R_{\theta JA}$       | Junction-to-ambient thermal resistance       | 108.1    | 150.2       | °C/W |  |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 45.8     | 43.9        | °C/W |  |
| $R_{\theta JB}$       | Junction-to-board thermal resistance         | 51.3     | 71.4        | °C/W |  |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 7.2      | 2.9         | °C/W |  |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 50.6     | 70.0        | °C/W |  |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | N/A      | N/A         | °C/W |  |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 7.6 Thermal Information: OPA4182

|                       |  | OPA4182  |      |
|-----------------------|--|----------|------|
|                       | THERMAL METRIC <sup>(1)</sup>                | D (SOIC) | UNIT |
|                       |  | 14 PINS  |      |
| $R_{\theta JA}$       | Junction-to-ambient thermal resistance       | 112.9    | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 50.8     | °C/W |
| R <sub>0JB</sub>      | Junction-to-board thermal resistance         | 56.2     | °C/W |
| $\Psi_{JT}$           | Junction-to-top characterization parameter   | 10.1     | °C/W |
| $\Psi_{JB}$           | Junction-to-board characterization parameter | 55.4     | °C/W |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | N/A      | °C/W |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



# 7.7 Electrical Characteristics

at  $T_A = 25^{\circ}$ C,  $V_{CM} = V_{OLIT} = V_S / 2$ , and  $R_{LOAD} = 10 \text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

|                              | PARAMETER                    | 2, and $R_{LOAD} = 10 \text{ k}\Omega$ connect  |  | MIN        | TYP                | MAX        | UNIT               |  |
|------------------------------|------------------------------|---|--|------------|--------------------|------------|--------------------|--|
| OFFSET                       | VOLTAGE                      |   |  |            |                    |            |                    |  |
|                              |                              |   |  |            | ±0.45              | ±4         |                    |  |
| Vos                          | Input offset voltage         | T <sub>A</sub> = 0°C to 85°C  |  |            | ±4                 | μV         |                    |  |
|                              |                              | T <sub>A</sub> = -40°C to +125°C  |  |            |                    | ±4         |                    |  |
|                              |                              |   | OPA182ID, OPA2182                                |            | ±0.003             | ±0.012     |                    |  |
| N                            |                              | T <sub>A</sub> = 0°C to 85°C  | OPA182IDBV,<br>OPA4182ID                         |            | ±0.003             | ±0.020     | \ //0.0            |  |
| dV <sub>OS</sub> /dT         | Input offset voltage drift   |   | OPA182ID, OPA2182                                |            | ±0.003             | ±0.012     | μV/°C              |  |
|                              |                              | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$  | OPA182IDBV,<br>OPA4182ID                         |            | ±0.003             | ±0.020     |                    |  |
|                              |                              |   | OPA182   |            | ±0.005             | ±0.07      |                    |  |
| PSRR                         | Power-supply rejection ratio | $T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$  | OPA2182,<br>OPA4182ID                            | ±0.005     |                    | ±0.05      | μV/V               |  |
| INPUT BI                     | AS CURRENT                   |   |  |            |                    |            |                    |  |
|                              |                              |   |  |            | ±50                | ±350       | pА                 |  |
| I <sub>B</sub>               | Input bias current           | $ Z_{IN}  = 100 \text{ k}\Omega    500 \text{ pF}$  | T <sub>A</sub> = 0°C to 85°C                     |            |                    | ±1         |                    |  |
| •в                           | mpar blac carroin            | ZIN 100 KII II 000 PI   | T <sub>A</sub> = -40°C to<br>+125°C              |            |                    | ±7         | nA                 |  |
| I <sub>OS</sub> Input offset |                              | Z <sub>IN</sub> = 100 kΩ    500 pF  |  |            | ±140               | ±700       | pA                 |  |
|                              | Input offset current         |   | $T_A = 0$ °C to 85°C                             |            |                    | ±2         |                    |  |
|                              | m,pat silvet salten          |   | T <sub>A</sub> = -40°C to<br>+125°C              |            |                    | ±3         | nA                 |  |
| NOISE                        |                              | 1   |  |            |                    |            |                    |  |
| _                            | Input voltage neige          | f = 0.1 Hz to 10 Hz   |  |            | 18                 |            | $\rm nV_{RMS}$     |  |
| En                           | Input voltage noise          | - 0.1 HZ tO 10 HZ   |  |            | 0.119              |            | $\mu V_{PP}$       |  |
|                              |                              | f = 10 Hz   |  |            | nV/√ <del>Hz</del> |            |                    |  |
| ۵                            | Input voltage noise          | f = 100 Hz  |  | 5.7<br>5.7 |                    |            |                    |  |
| e <sub>n</sub>               | density                      | f = 1 kHz   |  |            |                    |            | ]                  |  |
|                              |                              | f = 10 kHz  |  |            | 5.7                |            |                    |  |
| i <sub>n</sub>               | Input current noise density  | f = 1 kHz   |  |            | 165                |            | fA/√ <del>Hz</del> |  |
| INPUT V                      | OLTAGE                       |   |  |            |                    |            |                    |  |
| V <sub>CM</sub>              | Common-mode voltage range    |   |  | (V-) - 0.1 |                    | (V+) - 2.5 | V                  |  |
|                              |                              |   | V <sub>S</sub> = ±2.25 V                         | 120        | 140                |            |                    |  |
|                              |                              | $(V-) - 0.1 V \le V_{CM} \le (V+) - 2.5$  | V <sub>S</sub> = ±18 V, OPA182                   | 141        | 168                |            |                    |  |
|                              | Common-mode                  | V   | V <sub>S</sub> = ±18<br>V, OPA2182,<br>OPA4182ID | 143        | 168                |            |                    |  |
| CMRR                         | rejection ratio              | $(V-) - 0.1 V \le V_{CM} \le (V+) - 2.5$  | V <sub>S</sub> = ±2.25 V                         | 120        |                    |            | dB                 |  |
|                              |                              | $V_{A} = -40^{\circ}\text{C to } +125^{\circ}\text{C}$  | V <sub>S</sub> = ±18 V, OPA182,<br>OPA2182       | 140        |                    |            |                    |  |
|                              |                              | $(V-) \le V_{CM} \le (V+) - 2.5 \text{ V},$<br>$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$ | V <sub>S</sub> = ±18 V,<br>OPA4182ID             | 130        |                    |            |                    |  |



# 7.7 Electrical Characteristics (continued)

at  $T_A$  = 25°C,  $V_{CM}$  =  $V_{OUT}$  =  $V_S$  / 2, and  $R_{LOAD}$  = 10 k $\Omega$  connected to  $V_S$  / 2 (unless otherwise noted)

|                   | PARAMETER                         | TEST CONDIT   | IONS  | MIN       | TYP          | MAX    | UNIT     |  |
|-------------------|-----------------------------------|---|---|-----------|--------------|--------|----------|--|
| INPUT IN          | /IPEDANCE                         |   |   |           |              |        |          |  |
| z <sub>id</sub>   | Differential input impedance      |   |   |           | 0.1    3.7   |        | GΩ    pF |  |
| z <sub>ic</sub>   | Common-mode input impedance       |   |   |           | 60    2.3    |        | TΩ    pF |  |
| OPEN-LO           | OOP GAIN                          |   |   |           |              |        |          |  |
|                   |                                   |   | OPA182, OPA2182   | 150       | 170          |        |          |  |
|                   |                                   | $V_S = \pm 18 \text{ V},$<br>$(V-) + 0.3 \text{ V} < V_O < (V+) - 0.3 \text{ V},$ | OPA4182ID   | 145       | 170          |        |          |  |
| ^                 | Open leen voltege gein            | $R_{LOAD} = 10 \text{ k}\Omega$   | T <sub>A</sub> = -40°C to<br>+125°C                     | 146       |              |        | ٩D       |  |
| A <sub>OL</sub>   | Open-loop voltage gain            |   | OPA182, OPA2182   | 150       | 170          |        | dB       |  |
|                   |                                   | $V_S = \pm 18 \text{ V},$<br>$(V-) + 0.6 \text{ V} < V_O < (V+) - 0.6 \text{ V},$ | OPA4182ID   | 145       | 170          |        |          |  |
|                   |                                   | $R_{LOAD} = 2 k\Omega$  | T <sub>A</sub> = -40°C to<br>+125°C                     | 140       |              |        |          |  |
| FREQUE            | NCY RESPONSE                      |   |   |           |              |        |          |  |
| UGB               | Unity-gain bandwith               | A <sub>V</sub> = 1  |   |           | 3.6          |        | MHz      |  |
| GBW               | Gain-bandwith product             | A <sub>V</sub> = 1000   |   |           | 5            |        | MHz      |  |
| SR                | Slew rate                         | Gain = 1, 10-V step   |   |           | 10           |        | V/µs     |  |
| THD+N             | Total harmonic distortion + noise | Gain = 1, f = 1 kHz, V <sub>O</sub> = 3.5 V <sub>RN</sub>                         | IS  | 0         | .00008%      |        |          |  |
| Crosstalk         | Craestalls                        | ODA 2402  | At dc   |           | 150          |        | ٩D       |  |
|                   | OPA2182                           | f = 10 kHz  |   | 120       |              | dB     |          |  |
|                   |                                   | To 0.1%   | V <sub>S</sub> = ±18 V, gain = 1,<br>10-V step          |           | 1.3          |        |          |  |
| t <sub>S</sub>    | Settling time                     | To 0.01%  | V <sub>S</sub> = ±18 V, gain = 1,<br>10-V step, falling |           | 1.7          | 1.7 μs |          |  |
|                   |                                   | 10 0.0170   | V <sub>S</sub> = ±18 V, gain = 1,<br>10-V step, rising  |           | 3.4          |        |          |  |
| t <sub>OR</sub>   | Overload recovery time            | V <sub>IN</sub> × gain = V <sub>S</sub> = ±18V                                    |   |           | 220          |        | ns       |  |
| OUTPUT            | •                                 |   |   |           |              |        |          |  |
|                   |                                   |   | No load   |           | 5            | 15     |          |  |
|                   |                                   | Positive rail   | $R_{LOAD}$ = 10 k $\Omega$                              |           | 20           | 110    |          |  |
|                   |                                   |   | $R_{LOAD} = 2 k\Omega$                                  |           | 80           | 500    |          |  |
| $V_{O}$           | Voltage output swing from rail    |   | No load   |           | 5            | 15     | mV       |  |
|                   | inom rail                         | Negative rail   | R <sub>LOAD</sub> = 10 kΩ                               |           | 20           | 110    |          |  |
|                   |                                   |   | $R_{LOAD} = 2 k\Omega$                                  |           | 80           | 500    |          |  |
|                   |                                   | $T_A = -40$ °C to +125°C, both rails  |   |           | 20           | 120    |          |  |
| I <sub>SC</sub>   | Short-circuit current             |   |   |           | ±65          |        | mA       |  |
| C <sub>LOAD</sub> | Capacitive load drive             |   |   | See Typic | al Character | istics | pF       |  |
| Z <sub>O</sub>    | Open-loop output impedance        | f = 1 MHz   |   |           | 320          |        | Ω        |  |
| POWER             | SUPPLY                            | 1   |   |           |              |        |          |  |
|                   |                                   |   | T <sub>A</sub> = 25°C                                   | 0.85      |              | 1      |          |  |
| $I_Q$             | Quiescent current per amplifier   | $V_S = \pm 2.25 \text{ V to } \pm 18 \text{ V}$                                   | T <sub>A</sub> = -40°C to<br>+125°C                     |           |              | 1.1    | mA       |  |



# 7.8 Typical Characteristics

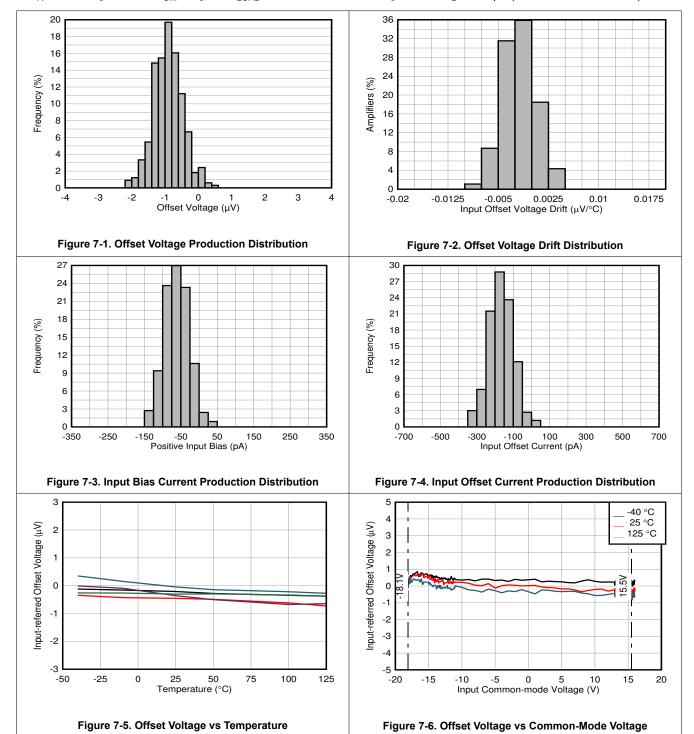
at  $T_A$  = 25°C,  $V_S$  = ±18 V,  $V_{CM}$  =  $V_S$  / 2,  $R_{LOAD}$  = 10 k $\Omega$  connected to  $V_S$  / 2, and  $C_L$  = 100 pF (unless otherwise noted)

**Table 7-1. Typical Characteristic Graphs** 

| DESCRIPTION  | FIGURE                   |
|--|--------------------------|
| Offset Voltage Production Distribution                 | Figure 7-1               |
| Offset Voltage Drift Distribution From –40°C to 125°C  | Figure 7-2               |
| Input Bias Current Production Distribution             | Figure 7-3               |
| Input Offset Current Production Distribution           | Figure 7-4               |
| Offset Voltage vs Temperature                          | Figure 7-5               |
| Offset Voltage vs Common-Mode Voltage                  | Figure 7-6               |
| Offset Voltage vs Supply Voltage                       | Figure 7-7               |
| Open-Loop Gain and Phase vs Frequency                  | Figure 7-8               |
| Closed-Loop Gain vs Frequency                          | Figure 7-9               |
| Input Bias Current vs Common-Mode Voltage              | Figure 7-10              |
| Input Bias Current and Offset vs Temperature           | Figure 7-11              |
| Output Voltage Swing vs Output Current (Sourcing)      | Figure 7-12              |
| Output Voltage Swing vs Output Current (Sinking)       | Figure 7-13              |
| CMRR and PSRR vs Frequency                             | Figure 7-14              |
| CMRR vs Temperature                                    | Figure 7-15              |
| PSRR vs Temperature                                    | Figure 7-16              |
| 0.1-Hz to 10-Hz Voltage Noise                          | Figure 7-17              |
| Input Voltage Noise Spectral Density vs Frequency      | Figure 7-18              |
| THD+N Ratio vs Frequency                               | Figure 7-19              |
| THD+N vs Output Amplitude                              | Figure 7-20              |
| Quiescent Current vs Supply Voltage                    | Figure 7-21              |
| Quiescent Current vs Temperature                       | Figure 7-22              |
| Open-Loop Gain vs Temperature (10-kΩ)                  | Figure 7-23              |
| Open-Loop Output Impedance vs Frequency                | Figure 7-24              |
| Small-Signal Overshoot vs Capacitive Load (10-mV Step) | Figure 7-25, Figure 7-26 |
| No Phase Reversal                                      | Figure 7-27              |
| Positive Overload Recovery                             | Figure 7-28              |
| Negative Overload Recovery                             | Figure 7-29              |
| Small-Signal Step Response (10-mV Step)                | Figure 7-30, Figure 7-31 |
| Large-Signal Step Response (10-V Step)                 | Figure 7-32, Figure 7-33 |
| Settling Time  | Figure 7-34              |
| Short Circuit Current vs Temperature                   | Figure 7-35              |
| Maximum Output Voltage vs Frequency                    | Figure 7-36              |
| EMIRR vs Frequency                                     | Figure 7-37              |
| Channel Separation                                     | Figure 7-38              |

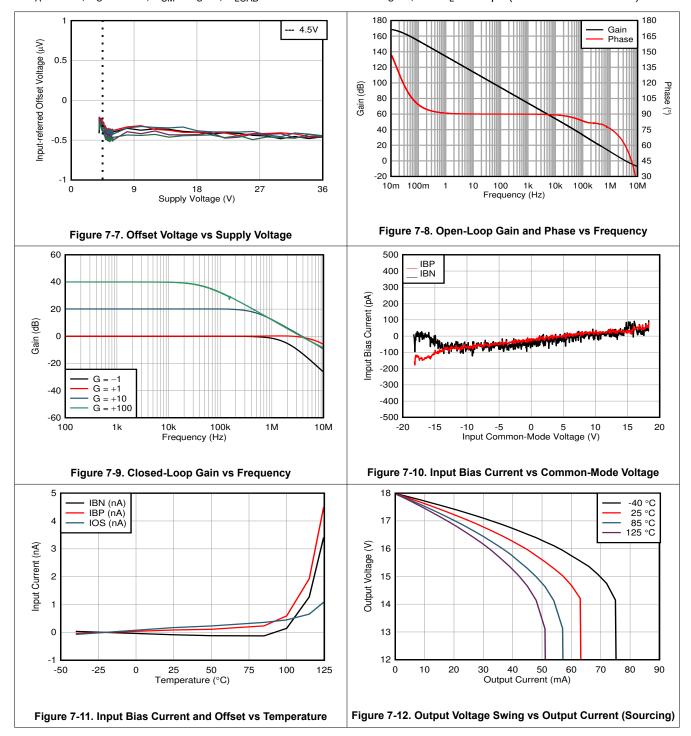


at  $T_A = 25$ °C,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_{LOAD} = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF (unless otherwise noted)



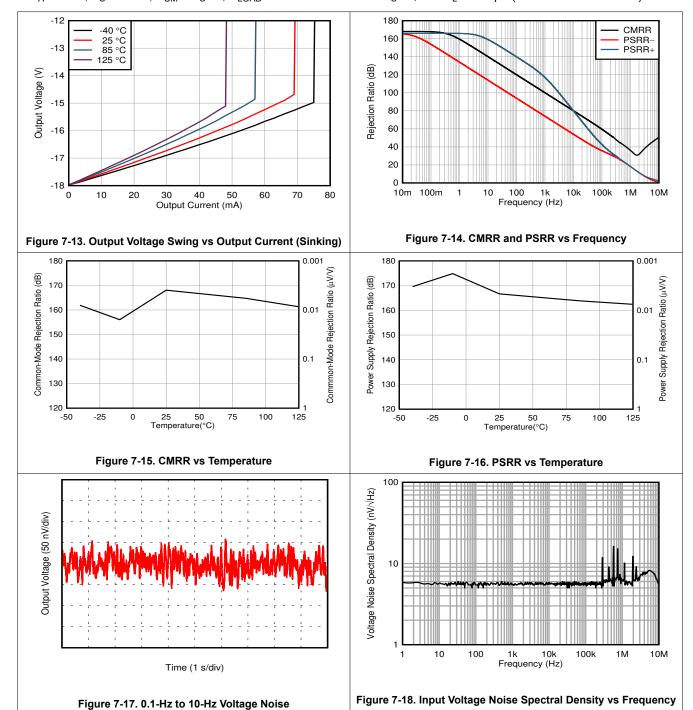


at  $T_A$  = 25°C,  $V_S$  = ±18 V,  $V_{CM}$  =  $V_S$  / 2,  $R_{LOAD}$  = 10 k $\Omega$  connected to  $V_S$  / 2, and  $C_L$  = 100 pF (unless otherwise noted)



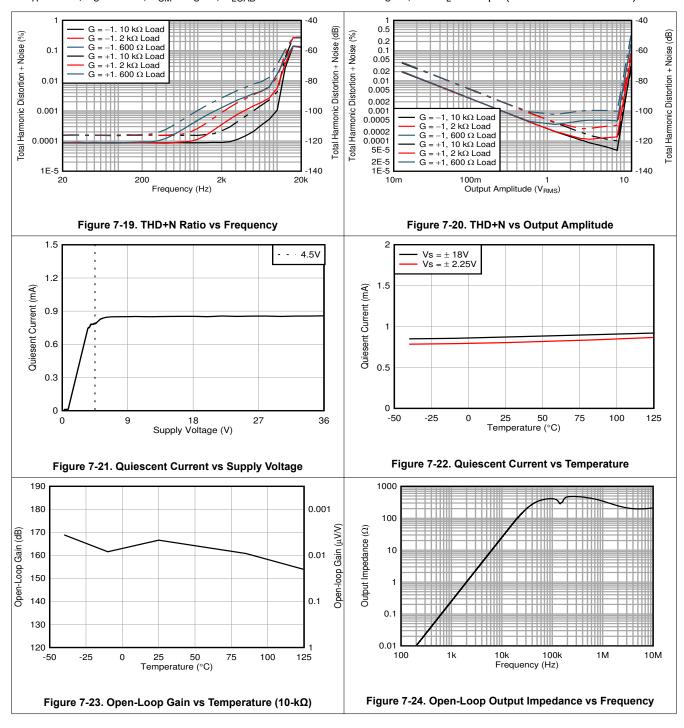


at  $T_A = 25$ °C,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_{LOAD} = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF (unless otherwise noted)



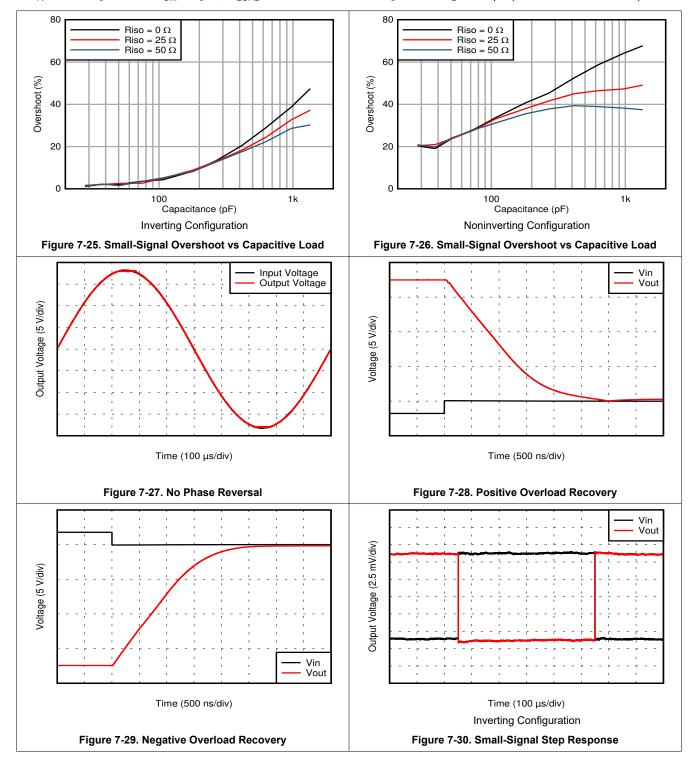


at  $T_A$  = 25°C,  $V_S$  = ±18 V,  $V_{CM}$  =  $V_S$  / 2,  $R_{LOAD}$  = 10 k $\Omega$  connected to  $V_S$  / 2, and  $C_L$  = 100 pF (unless otherwise noted)



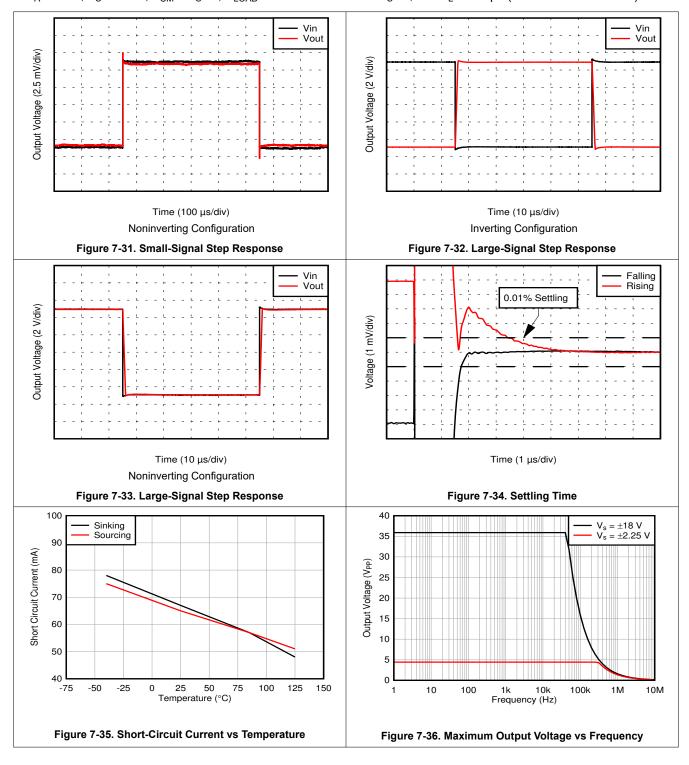


at  $T_A = 25$ °C,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_{LOAD} = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF (unless otherwise noted)



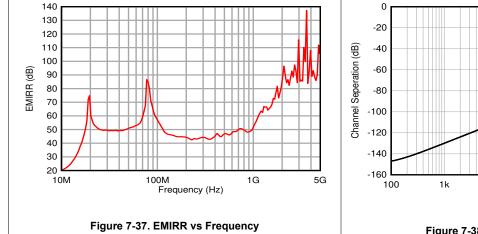


at  $T_A = 25$ °C,  $V_S = \pm 18$  V,  $V_{CM} = V_S / 2$ ,  $R_{LOAD} = 10$  k $\Omega$  connected to  $V_S / 2$ , and  $C_L = 100$  pF (unless otherwise noted)





at  $T_A$  = 25°C,  $V_S$  = ±18 V,  $V_{CM}$  =  $V_S$  / 2,  $R_{LOAD}$  = 10 k $\Omega$  connected to  $V_S$  / 2, and  $C_L$  = 100 pF (unless otherwise noted)



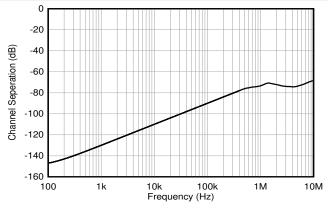


Figure 7-38. Channel Separation

# **8 Detailed Description**

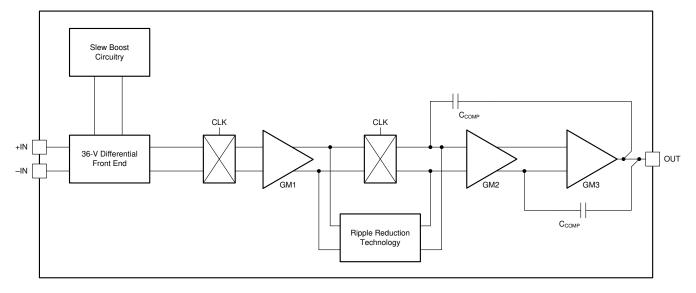
#### 8.1 Overview

The OPAx182 family of operational amplifiers combine precision offset and drift with excellent overall performance, making these devices a great choice for many precision applications. The precision offset drift of only 0.005  $\mu$ V/°C provides stability over the entire temperature range. In addition, these devices offer excellent linear performance with high CMRR, PSRR, and A<sub>OL</sub>. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- $\mu$ F capacitors are adequate. See the *Layout Guidelines* section for details and a layout example.

The OPAx182 are zero-drift, MUX-friendly, rail-to-rail output operational amplifiers. The devices operate from 4.5 V to 36 V, are unity-gain stable, and a great choice for a wide range of general-purpose and precision applications. The zero-drift architecture provides ultra-low input offset voltage and near-zero input offset voltage drift over temperature and time. This choice of architecture also offers outstanding ac performance, such as ultra-low broadband noise, zero flicker noise, and outstanding distortion performance when operating below the chopper frequency.

# 8.2 Functional Block Diagram

The functional block diagram shows a representation of the proprietary OPAx182 architecture.



#### 8.3 Feature Description

The OPAx182 operational amplifiers have several integrated features that help maintain a high level of precision throughout all operating conditions. These features include phase-reversal protection, input bias current clock feedthrough and MUX-friendly inputs.

#### 8.3.1 Phase-Reversal Protection

The OPAx182 have an internal phase-reversal protection. Many op amps exhibit a phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The OPAx182 input prevents phase reversal with excessive common-mode voltage. Instead, the output limits into the appropriate rail. This performance is shown in Figure 8-1.

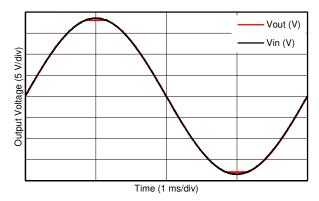


Figure 8-1. No Phase Reversal

#### 8.3.2 Input Bias Current Clock Feedthrough

Zero-drift amplifiers such as the OPAx182 use switching on the inputs to correct for the intrinsic offset and drift of the amplifier. Charge injection from the integrated switches on the inputs can introduce short transients in the input bias current of the amplifier. The extremely short duration of these pulses prevents the pulses from amplifying; however, the pulses can be coupled to the output of the amplifier through the feedback network. The most effective method to prevent transients in the input bias current from producing additional noise at the amplifier output is to use a low-pass filter such as an RC network.

#### 8.3.3 EMI Rejection

The OPAx182 use integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI interference from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx182 benefit from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. Figure 8-2 shows the results of this testing on the OPAx182. Table 8-1 lists the EMIRR +IN values for the OPAx182 at particular frequencies commonly encountered in real-world applications. Applications listed in Table 8-1 can be centered on or operated near the particular frequency shown. Detailed information can also be found in the *EMI Rejection Ratio of Operational Amplifiers* application report, available for download from www.ti.com.

The electromagnetic interference (EMI) rejection ratio, or EMIRR, describes the EMI immunity of operational amplifiers. An adverse effect that is common to many op amps is a change in the offset voltage as a result of RF signal rectification. An op amp that is more efficient at rejecting this change in offset as a result of EMI has a higher EMIRR and is quantified by a decibel value. Measuring EMIRR can be performed in many ways, but this section provides the EMIRR +IN, which specifically describes the EMIRR performance when the RF signal is applied to the noninverting input pin of the op amp. In general, only the noninverting input is tested for EMIRR for the following three reasons:

- Op amp input pins are known to be the most sensitive to EMI, and typically rectify RF signals better than the supply or output pins.
- The noninverting and inverting op amp inputs have symmetrical physical layouts and exhibit nearly matching EMIRR performance
- EMIRR is more simple to measure on noninverting pins than on other pins because the noninverting input terminal can be isolated on a PCB. This isolation allows the RF signal to be applied directly to the noninverting input terminal with no complex interactions from other components or connecting PCB traces.

High-frequency signals conducted or radiated to any op amp pin can result in adverse effects because there is insufficient amplifier loop gain to correct for signals with spectral content outside the bandwidth. Conducted or radiated EMI on inputs, power supply, or output can result in unexpected dc offsets, transient voltages, or other unknown behavior. Take care to properly shield and isolate sensitive analog nodes from noisy radio signals and digital clocks and interfaces.

The EMIRR +IN of the OPAx182 is plotted versus frequency as shown in Figure 8-2. If available, any dual and quad op amp device versions have nearly similar EMIRR +IN performance. The OPAx182 gain bandwidth is 5 MHz. EMIRR performance below this frequency denotes interfering signals that fall within the op amp bandwidth.

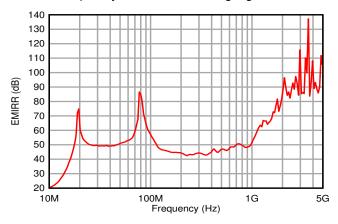


Figure 8-2. EMIRR Testing

Table 8-1. OPAx182 EMIRR IN+ for Frequencies of Interest

| FREQUENCY | APPLICATION AND ALLOCATION   | EMIRR IN+ |
|-----------|--|-----------|
| 400 MHz   | Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications   | 44.9 dB   |
| 900 MHz   | Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications                        | 48.4 dB   |
| 1.8 GHz   | GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)  | 81.7 dB   |
| 2.4 GHz   | 802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz) | 87.9 dB   |
| 3.6 GHz   | Radiolocation, aero communication and navigation, satellite, mobile, S-band  | 137.2 dB  |
| 5 GHz     | 802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)  | 99.2 dB   |

#### 8.3.4 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. See Figure 8-3 for an illustration of the ESD circuits contained in the OPAx182 (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, high-current pulse while discharging through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent damage. The energy absorbed by the protection circuitry is then dissipated as heat.

When an ESD voltage develops across two or more amplifier device pins, current flows through one or more steering diodes. Depending on the path that the current takes, the absorption device can activate. The absorption device has a trigger or threshold voltage that is greater than the normal operating voltage of the OPAx182 but less than the device breakdown voltage level. When this threshold is exceeded, the absorption device quickly activates and clamps the voltage across the supply rails to a safe level.

When the op amp connects into a circuit (as shown in Figure 8-3), the ESD protection components are intended to remain inactive and do not become involved in the application circuit operation. However, circumstances can arise where an applied voltage exceeds the operating voltage range of a given pin. If this condition occurs, there is a risk that some internal ESD protection circuits are biased on, and conduct current. Any such current flow occurs through steering-diode paths and rarely involves the absorption device.

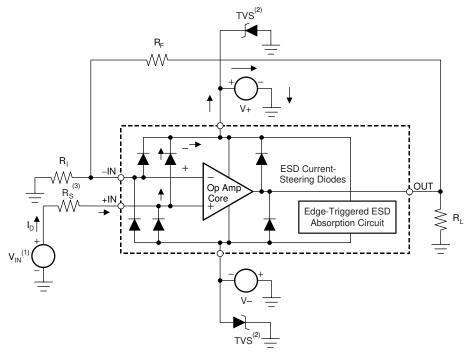
Figure 8-3 shows a specific example where the input voltage  $(V_{IN})$  exceeds the positive supply voltage (V+) by 500 mV or more. Much of what happens in the circuit depends on the supply characteristics. If V+ can sink the current, one of the upper input steering diodes conducts and directs current to  $+V_S$ . Excessively high current levels can flow with increasingly higher  $V_{IN}$ . As a result, the data sheet specifications recommend that applications limit the input current to 10 mA.

If the supply is not capable of sinking the current,  $V_{\text{IN}}$  can begin sourcing current to the operational amplifier, and then take over as the source of positive supply voltage. The danger in this case is that the voltage can rise to levels that exceed the operational amplifier absolute maximum ratings.

Another common question involves what happens to the amplifier if an input signal is applied to the input while the power supplies V+ or V- are at 0 V. Again, this question depends on the supply characteristic while at 0 V, or at a level below the input signal amplitude. If the supplies appear as high impedance, then the operational amplifier supply current can be supplied by the input source through the current-steering diodes. This state is not a normal bias condition; the amplifier most likely does not operate normally. If the supplies are low impedance, then the current through the steering diodes can become quite high. The current level depends on the ability of the input source to deliver current, and any resistance in the input path.

If there is any uncertainty about the ability of the supply to absorb this current, external Zener diodes must be added to the supply pins, as shown in Figure 8-3. The Zener voltage must be selected such that the diode does not turn on during normal operation. However, the Zener voltage must be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe operating supply voltage level.





- (1)  $V_{IN} = V + + 500 \text{ mV}.$
- (2) TVS: 40 V >  $V_{\text{TVSBR (min)}}$  > V+, where  $V_{\text{TVSBR (min)}}$  is the minimum specified value for the transient voltage suppressor breakdown voltage.
- (3) Suggested value is approximately 5 k $\Omega$  in overvoltage conditions.

Figure 8-3. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application

#### 8.3.5 MUX-Friendly Inputs

The OPAx182 feature a proprietary input stage design that allows an input differential voltage to be applied while maintaining high input impedance. Typically, high-voltage CMOS or bipolar-junction input amplifiers feature antiparallel diodes that protect input transistors from large  $V_{GS}$  voltages that can exceed the semiconductor process maximum and permanently damage the device. Large  $V_{GS}$  voltages can be forced when applying a large input step, switching between channels, or attempting to use the amplifier as a comparator. For more information, see the *MUX-Friendly Precision Operational Amplifiers* application brief.

The OPAx182 solve these problems with a switched-input technique that prevents large input bias currents when large differential voltages are applied. This input architecture solves many issues seen in switched or multiplexed applications, where large disruptions to RC filtering networks are caused by fast switching between large potentials. The OPAx182 offer outstanding settling performance because of these design innovations, along with built-in slew rate boost and wide bandwidth. The OPAx182 can also be used as a comparator. Differential and common-mode *Absolute Maximum Ratings* still apply relative to the power supplies.

#### 8.4 Device Functional Modes

The OPAx182 have a single functional mode, and are operational when the power-supply voltage is greater than  $4.5 \text{ V} (\pm 2.25 \text{ V})$ . The maximum power supply voltage is  $36 \text{ V} (\pm 18 \text{ V})$ .

# 9 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 9.1 Application Information

The OPAx182 operational amplifiers combine precision offset and drift with excellent overall performance, making these devices a great choice for many precision applications. The precision offset drift of only 0.005  $\mu$ V/°C provides stability over the entire temperature range. In addition, the devices combine excellent CMRR, PSRR, and A<sub>OL</sub> dc performance with outstanding low-noise operation. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- $\mu$ F capacitors are adequate.

The following application examples highlight only a few of the circuits where the OPAx182 can be used.

### 9.2 Typical Applications

#### 9.2.1 Strain Gauge Analog Linearization

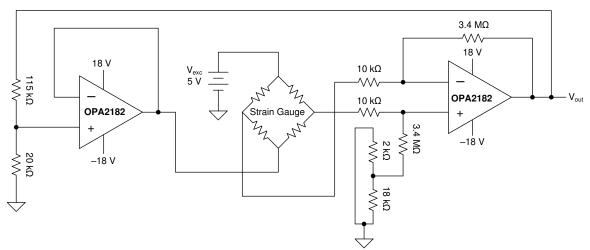


Figure 9-1. Bridge Sensor Analog Linearization With the OPA2182

#### 9.2.1.1 Design Requirements

A strain gauge is used to measure an alteration due to external force through the use of electrical resistance in a Wheatstone-bridge configuration. The Wheatstone bridge is used to precisely measure very low values of resistances down in the  $m\Omega$  range. An excitation voltage is applied to the bridge, and the output voltage across the middle of the bridge is measured. The total change in output voltage is relatively small, typically in the mV range. Therefore, an op amp is used to amplify the signal. The OPA2182 is designed to construct high-precision amplification.

Use the following parameters for this design example:

- Use the op-amp linear output operating range, which is usually specified under the AOL test conditions. The common-mode voltage is equal to the input signal.
- Use an op amp that does not add significant noise to the system or else the small output voltage from the Wheatstone bridge will be lost.
- The input signal must be gained; therefore, use an op amp with low input offset voltage (V<sub>OS</sub>)
- The input signal must be gained; therefore, use an op amp with enough open-loop gain to provide the required amplification

#### 9.2.1.2 Detailed Design Procedure

The bridge sensor signal flow model is shown in Figure 9-2.

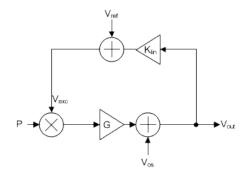


Figure 9-2. Bridge Sensor Signal Flow Model

The bridge sensor is modeled as a multiplier, with inputs from an excitation voltage and pressure sensor producing an output voltage given in Equation 1:

$$V_{bridge}(P, V_{exc}) = V_{exc} \times K_p(P)$$
(1)

 $K_p$  is the sensitivity of the bridge sensor, and is usually specified in mV/V. P represents the pressure relative to the range of the sensor, normalized to a scale from 0 to 1. Solving this equation with the variables given in the signal flow model and solving for  $V_{out}$  results in Equation 2:

$$V_{out}(P) = \frac{V_{OS} + V_{ref} \times G \times K_{p}(P)}{1 - G \times K_{lin} \times K_{p}(P)}$$
(2)

This equation has three variables,  $V_{OS}$ , G and  $K_{lin}$ , that require three equations to solve. To solve these equations, values of  $K_p$  at no load, midscale and full load conditions are needed for the sensor. With these values, the system can be linearized.

With known values for K<sub>p</sub>, K<sub>lin</sub> is calculated as shown in Equation 3:

$$K_{lin} = \frac{4 \times B_{v} \times V_{ref}}{(V_{out\_high} - V_{out\_low}) - 2 \times B_{v} \times (V_{out\_high} + V_{out\_low})}$$
(3)

In this equation, B<sub>v</sub> represents the bridge nonlinearity, which is calculated as shown in Equation 4:

$$B_{v} = \frac{K_{p}(0.5) - \frac{K_{p}(1) + K_{p}(0)}{2}}{K_{p}(1) - K_{p}(0)}$$
(4)

 $B_v$  is solved based on the sensor specifications, and the equation is then used to solve for  $K_{lin}$ . Next, the system gain is calculated using Equation 5 and Equation 6.

$$V_{out\_high} = \frac{V_{OS} + V_{ref} \times G \times K_{p}(1)}{1 - G \times K_{lin} \times K_{p}(1)}$$
(5)

$$V_{out\_high} = \frac{V_{OS} + V_{ref} \times G \times K_{p}(0)}{1 - G \times K_{lin} \times K_{p}(0)}$$
(6)

Solving for V<sub>OS</sub> in both equations and combining results in Equation 7.

$$V_{out\_high}(1 - G \times K_{lin} \times K_p(1)) - V_{ref} \times G \times K_p(1) = V_{out\_low}(1 - G \times K_{lin} \times K_p(0)) - V_{ref} \times G \times K_p(0) \tag{7}$$

Solving for G gives Equation 8.

$$G = \frac{V_{out\_high} - V_{out\_low}}{K_p(1) \times (K_{lin} \times V_{out\_high} + V_{ref}) - K_p(0) \times (K_{lin} \times V_{out\_low} + V_{ref})}$$
(8)

With both  $K_{lin}$  and G now calculated,  $V_{OS}$  is solved as shown in Equation 9.

$$V_{OS} = V_{out\_low} (1 - G \times K_{lin} \times K_{p}(0)) - V_{ref} \times G \times K_{p}(0)$$
(9)

For a sensor with a  $K_P$  of 0.0003 mV/V at no load, 0.0017 mV/V midscale and 0.00289 mV/V, the corresponding nonlinearity is approximately 4%. Solving for  $K_{lin}$ , G, and  $V_{OS}$  gives the values shown in Table 9-1.

**Table 9-1. Example Bridge Calculations** 

| K <sub>lin</sub> | 0.173913 |
|------------------|----------|
| G                | 323.8178 |
| VOS              | -0.48573 |

#### 9.2.1.3 Application Curves

Using the same  $K_P$  values used previously, the bridge nonlinearity is simulated as 4% peak, the output is linear from 0 V to 5 V, and the corrected system nonlinearity is approximately  $\pm 0.1\%$ .

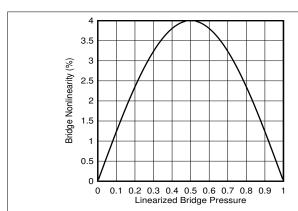


Figure 9-3. Bridge Nonlinearity

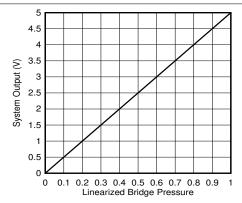


Figure 9-4. Bridge Output

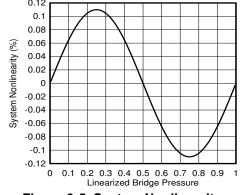


Figure 9-5. System Nonlinearity

#### 9.2.2 Rogowski Coil Integrator

Figure 9-6 shows the OPA2182 configured as an active integrator, level shifter and precision voltage reference buffer for a Rogowski coil used to indirectly measure the current of a protection relay with high accuracy. This design has two main signal paths: the first path is used to accurately measure the current flowing through the Rogowski coil, and a second high-speed path is used to detect a fast transient such as a short circuit. The OPA2182 is selected for this application thanks to the low offset voltage (0.45 μV) and offset drift (0.003 μV/°C) that minimize calibration requirements and maintain higher accuracy across the full temperature range. This device also features flat noise across a wide frequency range which includes dc which improves accuracy and repeatability across a wide range of input currents from the Rogowski coil. Additional information on this design can be found in the *Active Integrator for Rogowski Coil Reference Design with Improved Accuracy for Relay and Breaker*.

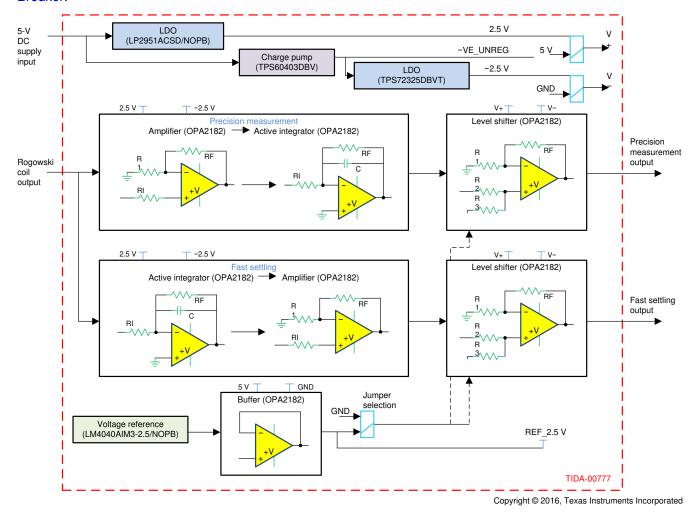


Figure 9-6. Programmable Power Supply

#### 9.2.3 System Examples

#### 9.2.3.1 24-Bit, Delta-Sigma, Differential Load Cell or Strain Gauge Sensor Signal Conditioning

The OPA2182 is used in a 24-bit, differential load cell or strain gauge sensor signal conditioning system alongside the ADS1225. The OPA2182 amplifier is configured in a two-amp instrumentation-amplifier (IA) configuration, and is band-limited to reduce noise and allow heavy capacitive drive. The load cell is powered by an excitation voltage (denoted  $V_{EX}$ ) of 5 V and provides a differential voltage proportional to force applied. The differential voltage can be quite small and both outputs are biased to  $V_{EX}$  / 2.

In this example, the OPA2182 is employed here because of the excellent input offset voltage (0.45  $\mu$ V) and input offset voltage drift (0.003  $\mu$ V/°C), the low broadband noise (5.7 nV/ $\sqrt{\text{Hz}}$ ) and zero-flicker noise, and excellent linearity and high input impedance. The two-amp IA configuration removes the dc bias and amplifies the differential signal of interest and drives the 24-bit, delta-sigma ADS1225 analog-to-digital converter (ADC) for acquisition and conversion. The ADS1225 features a 100-SPS data rate, single-cycle settling, and simple conversion control with a dedicated START pin.

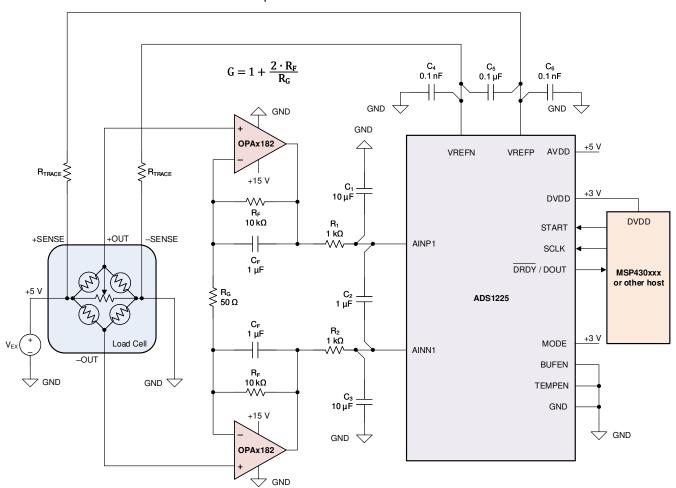
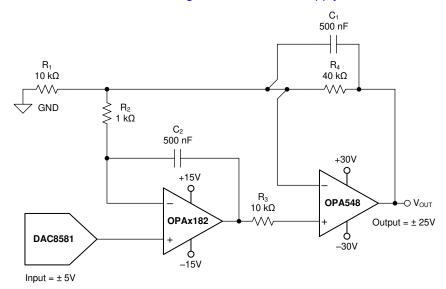


Figure 9-7. 24-Bit Differential Load Cell or Strain Gauge Sensor Signal Conditioning Schematic

#### 9.2.4 Programmable Power Supply

Figure 9-6 shows the OPAx182 configured as a precision programmable power supply using the 16-bit, voltage output DAC8581 and the OPA548 high-current amplifier. This application amplifies the digital-to-analog converter (DAC) voltage by a value of five, and handles a large variety of capacitive and current loads. The OPAx182 in the front-end provides precision and low drift across a wide range of inputs and conditions. Click the following link to download the TINA-TI<sup>TM</sup> software file: Programmable Power-Supply Circuit.

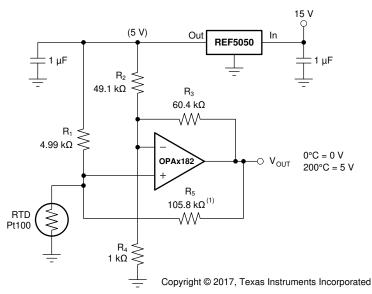


Copyright © 2017, Texas Instruments Incorporated

Figure 9-8. Programmable Power Supply

#### 9.2.5 RTD Amplifier With Linearization

See the *Analog Linearization of Resistance Temperature Detectors* analog design journal for an in-depth analysis of Figure 9-9. Click the following link to download the TINA-TI™ software file: RTD Amplifier with Linearization.



(1) R<sub>5</sub> provides positive-varying excitation to linearize output.

Figure 9-9. RTD Amplifier With Linearization

#### 9.3 Power Supply Recommendations

The OPAx182 is specified for operation from 4.5 V to 36 V (±2.25 V to ±18 V); many specifications apply from –40°C to +125°C. The *Typical Characteristics* presents parameters that can exhibit significant variance with regard to operating voltage or temperature.

#### **CAUTION**

Supply voltages larger than 40 V can permanently damage the device (see the *Aboslute Maximum Ratings*).

Place 0.1-µF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, see the *Layout* section.

#### 9.4 Layout

#### 9.4.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the op amp itself. Bypass capacitors reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
  - Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close as possible to the device. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective
  methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes.
  A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital
  and analog grounds paying attention to the flow of the ground current. For more detailed information, see The
  PCB is a component of op amp design.
- To reduce parasitic coupling, run the input traces as far away as possible from the supply or output traces. If
  these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed
  to in parallel with the noisy trace.
- Place the external components as close as possible to the device. As illustrated in Figure 9-10, keep RF and RG close to the inverting input to minimize parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Clean the PCB following board assembly.
- Any precision integrated circuit can experience performance shifts due to moisture ingress into the plastic package. Following any aqueous PCB cleaning process, bake the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low temperature, post cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

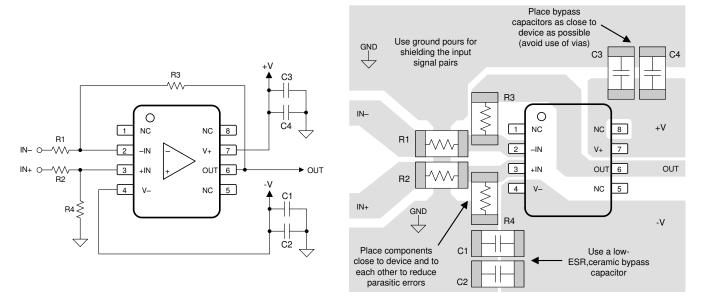
For the lowest offset voltage, avoid temperature gradients that create thermoelectric (Seebeck) effects in the thermocouple junctions formed from connecting dissimilar conductors.

- Use low thermoelectric-coefficient conditions (avoid dissimilar metals).
- Thermally isolate components from power supplies or other heat sources.
- · Shield operational amplifier and input circuitry from air currents, such as cooling fans.

Copyright © 2022 Texas Instruments Incorporated



#### 9.4.2 Layout Example



Copyright © 2017, Texas Instruments Incorporated

Figure 9-10. Operational Amplifier Board Layout for Difference Amplifier Configuration

# 10 Device and Documentation Support

# 10.1 Device Support

10.1.1 Development Support

10.1.1.1 PSpice® for TI

PSpice® for TI is a design and simulation environment that helps evaluate performance of analog circuits. Create subsystem designs and prototype solutions before committing to layout and fabrication, reducing development cost and time to market.

#### 10.1.1.2 TINA-TI™ Simulation Software (Free Download)

TINA-TI™ simulation software is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI simulation software is a free, fully-functional version of the TINA™ software, preloaded with a library of macromodels, in addition to a range of both passive and active models. TINA-TI simulation software provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Design tools and simulation web page, TINA-TI simulation software offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

#### **Note**

These files require that either the TINA software or TINA-TI software be installed. Download the free TINA-TI simulation software from the TINA-TI™ software folder.

#### 10.1.1.3 TI Reference Designs

TI reference designs are analog solutions created by TI's precision analog applications experts. TI reference designs offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits. TI reference designs are available online at <a href="https://www.ti.com/reference-designs">https://www.ti.com/reference-designs</a>.

#### **10.2 Documentation Support**

### 10.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, Zero-drift Amplifiers: Features and Benefits application report
- Texas Instruments, The PCB is a component of op amp design technical brief
- Texas Instruments, Operational amplifier gain stability, Part 3: AC gain-error analysis technical brief
- · Texas Instruments, Operational amplifier gain stability, Part 2: DC gain-error analysis technical brief
- Texas Instruments, Using infinite-gain, MFB filter topology in fully differential active filters technical brief
- Texas Instruments, Op Amp Performance Analysis application bulletin
- Texas Instruments, Single-Supply Operation of Operational Amplifiers application bulletin
- Texas Instruments, *Tuning in Amplifiers* application bulletin
- Texas Instruments, Shelf-Life Evaluation of Lead-Free Component Finishes application report
- Texas Instruments, Feedback Plots Define Op Amp AC Performance application bulletin
- Texas Instruments, EMI Rejection Ratio of Operational Amplifiers application report
- Texas Instruments, Analog Linearization of Resistance Temperature Detectors technical brief
- Texas Instruments, TI Precision Design TIPD102 High-Side Voltage-to-Current (V-I) Converter reference guide

#### 10.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

# **10.4 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 10.5 Trademarks

TINA-TI<sup>™</sup> and TI E2E<sup>™</sup> are trademarks of Texas Instruments.

TINA<sup>™</sup> is a trademark of DesignSoft, Inc.

Bluetooth® is a registered trademark of Bluetooth SIG, Inc.

PSpice® is a registered trademark of Cadence Design Systems, Inc.

All trademarks are the property of their respective owners.

# 10.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

# 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 8-Sep-2022

#### PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan     | Lead finish/<br>Ball material | MSL Peak Temp       | Op Temp (°C) | Device Marking<br>(4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|---------------------|--------------|-------------------------|---------|
|                  |        |              |                    |      |                |              | (6)                           |                     |              |                         |         |
| OPA182IDBVR      | ACTIVE | SOT-23       | DBV                | 5    | 3000           | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | 2RXQ                    | Samples |
| OPA182IDBVT      | ACTIVE | SOT-23       | DBV                | 5    | 250            | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | 2RXQ                    | Samples |
| OPA182IDR        | ACTIVE | SOIC         | D                  | 8    | 3000           | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP182                   | Samples |
| OPA182IDT        | ACTIVE | SOIC         | D                  | 8    | 250            | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP182                   | Samples |
| OPA2182ID        | ACTIVE | SOIC         | D                  | 8    | 75             | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP2182                  | Samples |
| OPA2182IDGKR     | ACTIVE | VSSOP        | DGK                | 8    | 2500           | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | 26RQ                    | Samples |
| OPA2182IDGKT     | ACTIVE | VSSOP        | DGK                | 8    | 250            | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | 26RQ                    | Samples |
| OPA2182IDR       | ACTIVE | SOIC         | D                  | 8    | 2500           | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP2182                  | Samples |
| OPA4182IDR       | ACTIVE | SOIC         | D                  | 14   | 3000           | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP4182                  | Samples |
| OPA4182IDT       | ACTIVE | SOIC         | D                  | 14   | 250            | RoHS & Green | SN                            | Level-2-260C-1 YEAR | -40 to 125   | OP4182                  | Samples |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: Til defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



# **PACKAGE OPTION ADDENDUM**

www.ti.com 8-Sep-2022

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



www.ti.com 9-Sep-2022

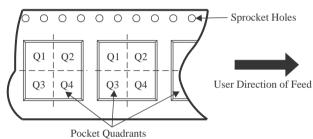
### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS KO P1 BO W Cavity A0

| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device       | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| OPA182IDBVR  | SOT-23          | DBV                | 5  | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| OPA182IDBVT  | SOT-23          | DBV                | 5  | 250  | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| OPA182IDR    | SOIC            | D                  | 8  | 3000 | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA182IDT    | SOIC            | D                  | 8  | 250  | 330.0                    | 12.4                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA2182IDGKR | VSSOP           | DGK                | 8  | 2500 | 330.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA2182IDGKT | VSSOP           | DGK                | 8  | 250  | 330.0                    | 12.4                     | 5.3        | 3.4        | 1.4        | 8.0        | 12.0      | Q1               |
| OPA2182IDR   | SOIC            | D                  | 8  | 2500 | 330.0                    | 12.8                     | 6.4        | 5.2        | 2.1        | 8.0        | 12.0      | Q1               |
| OPA4182IDR   | SOIC            | D                  | 14 | 3000 | 330.0                    | 16.4                     | 6.5        | 9.5        | 2.3        | 8.0        | 16.0      | Q1               |
| OPA4182IDT   | SOIC            | D                  | 14 | 250  | 330.0                    | 16.4                     | 6.5        | 9.5        | 2.3        | 8.0        | 16.0      | Q1               |



www.ti.com 9-Sep-2022



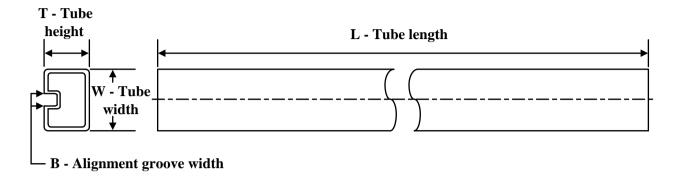
\*All dimensions are nominal

| 7 til dilliciololio die Hollindi |              |                 |      |      |             |            |             |
|----------------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device                           | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
| OPA182IDBVR                      | SOT-23       | DBV             | 5    | 3000 | 190.0       | 190.0      | 30.0        |
| OPA182IDBVT                      | SOT-23       | DBV             | 5    | 250  | 190.0       | 190.0      | 30.0        |
| OPA182IDR                        | SOIC         | D               | 8    | 3000 | 366.0       | 364.0      | 50.0        |
| OPA182IDT                        | SOIC         | D               | 8    | 250  | 366.0       | 364.0      | 50.0        |
| OPA2182IDGKR                     | VSSOP        | DGK             | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| OPA2182IDGKT                     | VSSOP        | DGK             | 8    | 250  | 366.0       | 364.0      | 50.0        |
| OPA2182IDR                       | SOIC         | D               | 8    | 2500 | 366.0       | 364.0      | 50.0        |
| OPA4182IDR                       | SOIC         | D               | 14   | 3000 | 366.0       | 364.0      | 50.0        |
| OPA4182IDT                       | SOIC         | D               | 14   | 250  | 366.0       | 364.0      | 50.0        |

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 9-Sep-2022

### **TUBE**



### \*All dimensions are nominal

| Device    | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|-----------|--------------|--------------|------|-----|--------|--------|--------|--------|
| OPA2182ID | D            | SOIC         | 8    | 75  | 509    | 7.9    | 3800   | 2.81   |



SMALL OUTLINE TRANSISTOR



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE



- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.



# D (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated